MONTE CARLO SIMULATION OF COMPLEX SYSTEM MISSION RELIABILITY

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ABSTRACT

A Monte Carlo methodology for the reliability simulation of highly redundant systems is presented. Two forms of importance sampling, forced transitions and failure biasing, allow large sets of continuous-time Markov equations to be simulated effectively and the results to be plotted as continuous functions of time. A modification of the sampling technique also allows the simulation of both nonhomogeneous Markov processes and of nonMarkovian processes involving the replacement of worn parts. A number of benchmark problems are examined. For problems with large numbers of components, Monte Carlo is found to result in decreases in computing times by as much as a factor of twenty from the Runge-Kutta Markov solver employed in the NASA code HARP.

1. INTRODUCTION

There is an increasing need to predict mission unreliability and related parameters for systems exhibiting very low rates of failure. Typically, such systems are designed in configurations with many component redundancies and are organized in such a manner that there are component dependencies in the forms of standby subsystems, shared-load components, and shared repair or fault handling faculties. The utility of probabilistic analysis based on combinatorial techniques may be extremely limited. In contrast, such systems may often be modeled as continuous-time Markov processes, particularly if the models are generalizable to include nonhomogeneous Markov processes.

While Markov processes may be an excellent modeling tool, difficulties arise in carrying out computations, particularly in models that are too large or complex to treat by conventional analytical means. As $n$, the number of components, increase the $2^n$ explosion of states means that very large systems of coupled differential equations must be solved. Moreover, these equations tend to be very stiff since the time constants involved may range from fault occurrences that are rare events even over weeks or months to fault handling mechanisms that take place in small fractions of a second. As a result, the number of distinct components that can be treated is severely restricted if deterministic methods are employed. If the time constants fall into two widely separated time domains, behavioral decomposition (Bavuso, et al., 1987) may be employed to treat the short time constant events as instantaneous changes of state. But difficulties may then arise when there is inadequate separation in the magnitudes of the time constants.
We have found that Monte Carlo methods may be an effective tool for treating the simulation of systems having highly redundant configurations of components (Lewis and Boehm, 1984; Lewis and Tu, 1986; Boehm, et al., 1988). Regardless of whether component dependencies are present, modeling the system as a continuous-time Markov process allows the average number of event samplings required per trial to be reduced to only slightly more than one. More important, however, is the use of a form of importance sampling that we refer to as forced transitions, to ensure that a substantial fraction of the independent trials will contribute to the tally of the system unreliability. Monte Carlo analysis may be further refined with a second form of importance sampling, referred to as failure biasing, that has the potential for eliminating the approximations inherent in behavioral decomposition. Finally, Monte Carlo tallies may be constructed to yield more than the traditional single answer results; tallies of reliability or other quantities of interest may be generated as continuous functions of time to provide more physical insight into the meaning of the results.

2. MONTE CARLO FORMULATION

For purposes of the Monte Carlo simulation the nonhomogeneous Markov equations are converted to semi-Markov equations. If $p_k(t)$ represents the probability that the system is in state $k$ at time $t$, then

$$\frac{\partial}{\partial t}p_k(t) = -\gamma_k p_k(t) + \sum_{k'} q(k|k',t) \gamma_k p_k(t),$$

where the initial conditions are given by

$$p_k(0) = \delta_{k0}.$$ 

If $\lambda_{jk}(t)$ is the transition rate from state $k$ to state $j$, then the net transition rate out of state $k$ is

$$\gamma_k = \sum_j \lambda_{jk}(t),$$

and the quantity

$$q(k|k',t) = \frac{\lambda_{kk'}(t)}{\gamma_k}$$

is the conditional probability of arrival in state $k$, given a transition out of state $k'$ at $t$.

In a Markov process the self-transition rates $\lambda_{kk}$ vanish. However since effective Monte Carlo sampling requires the values of $\gamma_k$ appearing in the Markov equation to be independent of time, we treat nonhomogeneous Markov processes by forcing the transition rates $\gamma_k$ to have positive value that are independent of time. This is accomplished by defining a fictitious self-transition rate

$$\lambda_{kk}(t) = \gamma_k - \sum_{j \neq k} \lambda_{jk}(t),$$

where $\gamma_k$ is taken to be sufficiently large that $\lambda_{kk}(t)$ will remain nonnegative. In cases where the transition rates either remain constant or increase with time this may be achieved by letting

$$\gamma_k = \sum_{j \neq k} \lambda_{jk}(T),$$

where $T$ is the mission time.

2.1. Analog Monte Carlo

Analog Monte Carlo trials are performed as indicated in Figure 1. The times to the successive transitions are determined by setting the cumulative distribution function

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\[ F(t';k') = 1 - e^{-\gamma_k(t'-t')} \]

equal to a uniformly distributed random number \( \xi \) and solving for \( t \),

\[ t = t' - \frac{1}{\gamma_k} \ln(1 - \xi) \, . \]

Figure 1: Monte Carlo Trial Procedure for a Design Life \( T \)

The new system state is determined by generating a second uniformly distributed random number \( \xi \) and choosing the state for which

\[ \frac{\lambda_{k,k'}(t)}{\gamma_k} \leq \xi \leq \frac{\lambda_{k+1,k'}(t)}{\gamma_k} \, . \]

This procedure is repeated until the mission time is exceeded or the system reaches an absorbing (i.e., failed) state. At any given time the unreliability is just the fraction of trials that have reached failed states.

2.2. Forced Transitions

In highly reliable systems the foregoing algorithm will in most cases require only one sampling per history since the first state transition is not likely to occur until \( t > T \). This also means that only a very small fraction of the histories will contribute to the tally, and as a result the variance in the result will tend to be large. To circumvent this difficulty we may modify the distribution of the time to the next transition to force additional transitions within the time interval \( 0 < t < T \) while modifying the tally such that the results are unbiased. The modified cumulative distribution is

\[ \tilde{F}(t';k') = \frac{1 - e^{-\gamma_k(t'-t')}}{1 - e^{-\gamma_k(T-t')}} \, , \quad t' < t < T \]

With the uniformly distributed random number \( \xi \), the time of the next transition is then determined from

\[ t = t' - \frac{1}{\gamma_k} \ln\left[ 1 - \xi \left[ 1 - e^{-\gamma_k(T-t')} \right] \right] \, . \]

To obtain an unbiased result a weight \( w_i \) is attached to each trial and initialized at \( w_i = 1. \) Each time that forced transition sampling is performed the weight is modified by

\[ w_i \rightarrow w_i \left[ 1 - e^{-\gamma_k(T-t')} \right] \, . \]

The tally for the unreliability is then

\[ u_T = \frac{1}{N} \sum_{t_i \leq T} w_i \, , \]

with a sampling variance given by

\[ S^2(u_T) = \frac{1}{N-1} \sum_{n=1}^{N} [w_n - u_T]^2 \, . \]
2.3. Failure Biasing

Forced transitions assure that faults will occur in a substantial fraction of the Monte Carlo trials. However in some situations the sampling may remain poor. In mechanical systems, for example, repair rates typically are orders of magnitude larger than component failure rates. Likewise, in avionic systems electronic fault handling systems result in state transition rates that are much faster than the rates at which failures are induced into the system. To further enhance the effectiveness of the Monte Carlo simulation the fraction of smaller probability failure transitions may be increased by the use of a second variance reduction technique which we refer to as failure biasing.

In failure biasing the transition probabilities \( q(k|k') \) are modified to increase the ratio of failures to other events such as successful fault handlings. We first divide the transitions out of state \( k' \) into to sets; \( \Lambda \) includes those resulting from component failures and \( R \) those resulting from successful repair or fault handling. We may then write

\[
\gamma_k = \sum_{j \in \Lambda_k} \lambda_{jk}(t) + \sum_{j \in R_k} \mu_{jk} .
\]

We require that some fraction \( x \) of the transitions come from the set \( \Lambda \). The biased transition probabilities are then

\[
\tilde{q}(k|k') = \frac{q(k|k')}{\sum_{k'' \in \Lambda} q(k''|k')} \cdot x , \quad k \in \Lambda ,
\]

and

\[
\tilde{q}(k|k') = \frac{q(k|k')}{\sum_{k'' \in \Lambda} q(k''|k')} (1 - x) , \quad k \in R
\]

To maintain unbiased results the trial weight is modified by

\[
w_i \rightarrow w_i \frac{1}{x} \sum_{k'' \in \Lambda} q(k''|k')
\]

for component failures and

\[
w_i \rightarrow w_i \frac{1}{(1 - x)} \sum_{k'' \in R} q(k''|k')
\]

for repair. In using failure biasing we typically choose \( x \) to be between 0.5 and 0.6; studies of model problems have indicated that values as high as 0.75 may be used before one begins to observe the increases in the sample variance that arise from improbable but very high weight histories (Kirsch, 1988).

3. APPLICATIONS

Two classes of problems are considered in order to examine the accuracy and efficiency of Monte Carlo methods. The first consists of simple hybrid redundant systems for which we have also obtained analytical solutions. By varying the ratio of failure to fault handling rate the ability of the variance reduction methods to provide accurate simulations can be determined for systems with very small failure probabilities. In the second class of problems are included two benchmark configurations for which computing times and deterministic solutions have been obtained using the NASA Hybrid Automated Reliability Predictor (HARP) (Bavuso, et al., 1987a, 1987b).

Behavioral composition is employed in the HARP code to separate fault/error-
handling models from the fault occurrence models. The code includes the capability for treating a variety of error handling models, while fault occurrence is modeled as a nonhomogeneous continuous-time Markov process. The imperfect coverage fault/error handling models are reduced to a set of transition probabilities, allowing the entire system to be treated with nonhomogeneous Markov equations in which only the longer time constants of fault occurrence appear. The HARP code solves the Markov equations by the Runge-Kutta method.

3.1. Hybrid Model Problem

We consider a simple hybrid (Lewis and Tu, 1986; Bavuso, et al., 1987) system for which we have obtained analytical solutions elsewhere (Kirsch, 1988). It consists of three units in a majority vote configuration with one spare. Each of the units including the spare has a constant failure rate \( \lambda \), where it is assumed that the spare can not fail until it is switched in. Coverage of the fault by switching in the spare takes place with a constant rate \( \upsilon \). The ten hour mission system failure probability is shown in Table 1 over a large range of parameters, with \( \lambda \) and \( \upsilon \) given in hrs\(^{-1}\). The ability of Monte Carlo simulation with variance reduction to provide accurate estimates of very small failure probabilities is clearly illustrated.

<table>
<thead>
<tr>
<th>( \lambda )</th>
<th>( \upsilon \lambda )</th>
<th>exact solution</th>
<th>Monte-Carlo solution</th>
<th>QVR</th>
<th>relative error</th>
</tr>
</thead>
<tbody>
<tr>
<td>( 10^{-2} )</td>
<td>( 10^{-5} )</td>
<td>0.2464 10(^{-2})</td>
<td>0.2507 10(^{-2})</td>
<td>0.08827</td>
<td>0.01745</td>
</tr>
<tr>
<td>( 10^{-3} )</td>
<td>( 10^{-8} )</td>
<td>0.2999 10(^{-5})</td>
<td>0.3073 10(^{-5})</td>
<td>0.09123</td>
<td>0.02471</td>
</tr>
<tr>
<td>( 10^{-4} )</td>
<td>( 10^{-10} )</td>
<td>0.3592 10(^{-8})</td>
<td>0.3667 10(^{-8})</td>
<td>0.07626</td>
<td>0.02088</td>
</tr>
<tr>
<td>( 10^{-5} )</td>
<td>( 10^{-12} )</td>
<td>0.6997 10(^{-11})</td>
<td>0.7136 10(^{-11})</td>
<td>0.02628</td>
<td>0.01545</td>
</tr>
<tr>
<td>( 10^{-6} )</td>
<td>( 10^{-14} )</td>
<td>0.6299 10(^{-13})</td>
<td>0.6371 10(^{-13})</td>
<td>0.01476</td>
<td>0.01143</td>
</tr>
</tbody>
</table>

3.2. Three-Processor Two-Memory One-Buss System

The detailed problem specification for the 3-processor, 2-memory 1-buss system is given elsewhere (Bavuso, et al., 1987). Briefly, the system is modeled by the Markov diagram shown in Figure 2, where \( \lambda \), \( \upsilon \) and \( \sigma \) represent the processor, memory and buss failure rates. The three numbers associated with each Markov state are the number of operational processors, memory units and buses, respectively, and F1 through F3 are states of system failure. Not shown are the direct transitions from each of the states to system failure that result from near-coincidence and single point failures. The relative frequencies of such failures are determined from the AIRES fault/error handling model (Bavuso, et al., 1987) and appear in the Markov equations as modifications of the state transition probabilities.

![Figure 2: Markov Representation of the 3-Processor, 2-Memory, 1-Buss System](image)

Figure 3 shows Monte Carlo results for the system unreliability over a mission time of ten hours. The data, given in Bavuso, et al., 1987, is for time-independent fault occurrence rates. The three lines correspond to the point estimate and the 68% confidence interval. The Monte Carlo results shown in Fig. 4 are for the same
system, but with Weibull distributions for fault occurrence rates; these have moduli of m = 2.5. In both cases the Monte Carlo simulations consisted of 10,000 trials.

![Graph](image)

Figure 3: Unreliability vs. Time for the 3-Processor, 2-Memory, 1-Buss System with Constant Failure Rates

![Graph](image)

Figure 4: Unreliability vs. Time for the 3-Processor, 2-Memory, 1-Buss System with Increasing Failure Rates

Table 2: Ten Hour Mission Unreliability for a 3-Processor 2-Memory 1-Buss System

<table>
<thead>
<tr>
<th>Constant Failure Rates</th>
<th>Monte Carlo</th>
<th>HARP</th>
</tr>
</thead>
<tbody>
<tr>
<td>Unreliability</td>
<td>1.498 (±0.034) 10^-4</td>
<td>1.521 10^-4</td>
</tr>
<tr>
<td>CPU sec.</td>
<td>56</td>
<td>-6</td>
</tr>
<tr>
<td>Weibull Failures</td>
<td>Monte Carlo</td>
<td>HARP</td>
</tr>
<tr>
<td>Unreliability</td>
<td>4.789 (±0.158) 10^-3</td>
<td>4.783 10^-3</td>
</tr>
<tr>
<td>CPU sec.</td>
<td>582</td>
<td>796</td>
</tr>
</tbody>
</table>

3.3. Jet Engine Control System

The jet engine controller problem, specified in detail elsewhere (Bavuso, et al., 1987), provides a basis for comparing the Monte Carlo and HARP codes for a system with a larger number of components. The CARE II model (Bavuso, et al., 1987) is used for error/fault-handling. The 20 component system has 171 minimum cut sets and is highly redundant as indicated by the fault tree representation shown in Figure 5. The Monte Carlo results for a 10 hour mission are shown in Figure 6. The Monte Carlo unreliability estimate of 1.073 (±0.087) 10^-5 compares well with the HARP result of 1.112 10^-5.
components. Such modeling increased the computing time by roughly a factor of three over the constant failure rate model but allows problems to be simulated by Monte Carlo that cannot be treated with HARP.

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REFERENCES


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